Confirming Synthesis Products Using Mass Peak Profiling from Selected Ion Recording Data (MPPSIRD)

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A crucial step in developing immunoassay methods for small molecules is synthesis of haptens. Determining the exact mass of the molecular ion of synthetic products provides incomplete confirmation. To reveal structural features of the molecule, purification or chromatography is required before using NMR or FTIR. In this study, HRMS provided structural information for a thermolabile, non-ionic, phosphorothionate compound in a synthetic mixture without prior separation. A direct insertion probe introduced the product into a VG70-250SE mass

spectrometer. Ions from the product and impurities

were separated by mass using HRMS rather than in the

original compounds. A fragmentation scheme based on

time domain by using chromatography to separate the

the unique compositions determined for the molecular

ion and fragment ions was consistent with the structural

INTRODUCTION

the "acceptable uncertainty" in the exact mass measurement must be

products, the list of elements can be limited to those in the reactants.

TOOLS

THE CORRECT

COMPOSITION

FOR SELECTING

increases the upper mass limit for which a

N, O, P, or S atoms.2

unique composition can usually be determined

from 150 Da to 600 Da for ions containing C, H,

The Journal of the American Society for Mass Spectrometry states that

assessed and all elemental compositions possible for an ion within that error

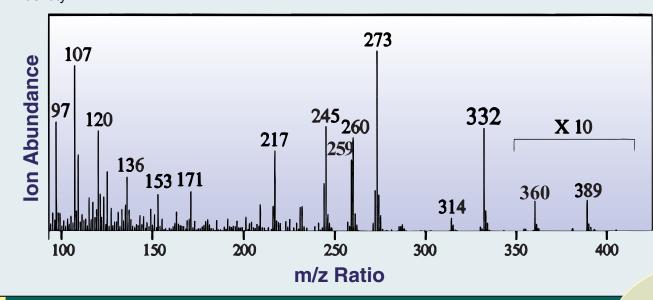
range must be considered. The number of compositions possible for an ion

increases rapidly for a given error limit as a function of the ion's mass and the

number of elements considered.² When confirming identities of synthetic

features of the desired product.

In this study, MPPSIRD and the PGM were used to determine the elemental composition of a synthesis product that was prepared by the Human Exposure Research Branch (EPA) to develop a new immunoassay.⁶ MPPSIRD was further employed to determine elemental compositions of fragment ions observed in the low resolution (1.000) full scan (50-700 Da) mass spectrum shown in Figure 1. From this information, structural features of the product were determined, to provide further confirmation of the product's



EXPERIMENTAL

SAMPLE

INTRODUCTION

A small amount of the synthesis product

was dissolved in about 1 mL of toluene. From

0.1 - 1 μL of the solution was injected within

before being pressed against the ion source

block. The block was at 250 °C and slowly

heated the probe tip. Gentle heating made

thermal decomposition of the analyte less

a 1.5-min period.

likely. Most of the product was volatilized over

the probe capillary and the solvent was

evaporated in a roughing vacuum region

APPLICATION TO **IDENTIFYING A** SYNTHESIS PRODUCT

> Figure 1. Low resolution mass spectrum corresponding to the maximum in the ior chromatogram for the m/z 332 ion. The ion abundances were magnified by 10 above 350 Da.

The low resolution mass spectrum corresponding to the maximum in the total ion chromatogram for the primary compound in the synthesis product is shown in Figure 1. The presumed molecular ion of the target product at m/z 332 and numerous possible fragment ions were observed. Ions with

RESULTS AND DISCUSSION

interest, since one might be the parent ion of the m/z 332 ion.



In Figure 5 is depicted a possible fragmentation scheme that yields all of the ions shown to be associated with the molecular ion. The compositions of the fragment ions and the neutral losses and rational explanations for formation of all the ions provide additional evidence that the target compound was synthesized. Although other fragment ions and neutral losses could be isolated the ions with high relative abundances that were investigated were sufficient to provide structura details of the molecule. Significant structural information was deduced from HRMS alone,

POSSIBLE

SCHEME

AND THE MOLECULAR ION esort to NMR or FTIR, which require purification of products before analysis

153.0139

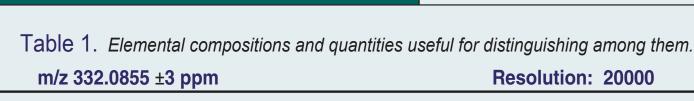
 $(C_4H_{10}O_2PS)$

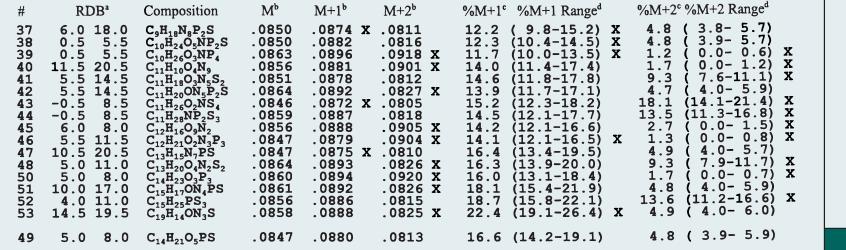
96.9513

OF THE MOLECULAR ION

The exact mass of the m/z 332 ion was determined to be 332.0855 \pm 0.0010 Da (\pm 3 ppm) from the mass peak profile in Figure 2b obtained at 20,000 resolution. The PGM determined that 53 compositions were possible within the error limits of the exact mass determination. In Table 1, 17 of the possible compositions are listed with the calculated mass defects for the M profile and the M+1 and M+2 partial profiles, as well as the calculated abundances of the M+1 and M+2 partial profiles relative to the M partial profile. The permissible ranges for %M+1 and %M+2 calculated by the PGM are shown in parentheses. The experimental values were determined from the partial profiles in Figure 2c. The error limits exceeded by the experimental results are marked with "X". Because only C, H, N, O, P and S atoms were present during synthesis, only the expected composition, C₁₄H₂₁O₅PS, was consistent with the five quantities; the other 52 compositions were not.

Using full and partial profiles acquired at 10,000 and 20,000 resolution, the compositions of the m/z 360 and m/z 389 ions seen in low abundance in Figure 1 were determined using the PGM to be C₁₆H₂₅O₅PS⁺⁻ and C₁₇H₂₆O₄PS₂⁺, respectively, based on the five criteria. Because the m/z 332 ion contains one more O atom than the m/z 389 ion, the m/z 332 ion was not formed from the m/z 389 ion. A linked scan for m/z 360 indicated that the m/z 332 ion was not formed from the m/z 360 ion either.





^aRings and double bonds: minimum with valences of 3, 3, and 2 for N, P, and S, and maximum with valences of 5, 5, and 6 for N, P, and S; based on partial profiles that provide maximum area; cbased on full profiles; dbased on partial profiles centered about the calculated mass of the hypothetical composition, ±1 mass increment at ±10% of resolution, and isotopic abundance.⁵ An "x" indicates application of this criterion will reject this composition if the hypothetical composition is correct.

Ions are easily correlated with GC/MS by superimposing normalized ion chromatograms of the molecular ion and the suspected fragment ions. Volatilization from a probe, however, provides much less separation capability than a GC. To compensate for limited separation in the time domain, high mass resolution was used to provide separation in the mass domain. Hence, ion chromatograms obtained with high mass resolution were still useful for correlating ions. When two ion chromatograms did not overlap as in Figure 3a, the ions originated from different compounds. When two ion chromatograms overlapped as in

Figure 3b, they usually originated from the same compound. For m/z ratios greater than 133, linked scans confirmed that several ions were daughter ions. For example, the linked scan in Figure 4 indicated that ions with m/z 314, 273, 260, 245, 217, and 171 were

Multiple ions were found for some m/z ratios. In these cases, ion chromatograms acquired with 10,000-24,000 mass resolution alone were used to find daughter ions. For example, the ion chromatograms for two of four ions with a nominal mass of 97 Da are shown in Figures 3a and 3b. The trace for 96.9514 (H₂O₂PS⁺, characteristic of phosphoronates)

Experimental Error

245.0399 -0.2

Mass

5.0 8.0 334.0818 +0.5

5.0 8.0 332.0855 +0.8

6.0 9.0 314.0730 -1.2

4.5 7.5 273.0711 -0.3

4.0 7.0 260.0631 -0.5

4.5 7.5 259.0557 -0.1

-0.5 2.5 171.0243 -0.2

0.5 3.5 153.0135 -0.4

5.5 6.5 153.0104 -0.1

5.0 7.0 136.0345 -0.2

0.5 3.5 96.9514 +0.1

5.0 120.0573 -0.2

4.5 107.0499 +0.2

Experimental Error

18.0117 +1.1

Mass

59.0136

72.0216

73.0290

87.0448

115.0759

161.0604

179.0712

179.0743

196.0502

4.5 7.5 217.0088

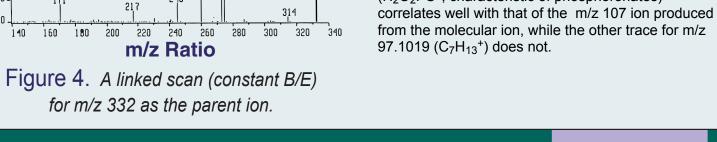


Table 2. Exact masses for ions

related to m/z 332 ion.

 $^{13}CC_{13}H_{21}O_{5}PS^{b}$ 5.0 8.0 333.0881 +0.1

4.5 7.5

^aRings and double bonds: minimum with valences

of 3, 3, and 2 for N, P, and S, and maximum with valences

of 5, 5, and 6 for N, P, and S; bmost abundant M+1 or M+2 ion.

Table 3. Exact masses of

neutral losses determined as

mass differences between the

molecular and fragment ions

Losses

2C,3H,20

3C,4H,20

3C,5H,20

4C,7H,20

6C,11H,20

10C,9H,2O

10C,11H,30

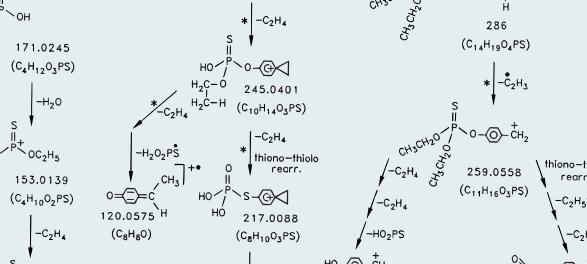
7C,15H,30,S

6C,13H,50,P

6C,13H,4O,P,S 212.0274

14C,19H,30 235.1333

7C,14H,4O,P,S 225.0348



107.0497 153.0105 (C₇H₆O₂P) Plausible fragmentation scheme for the ions , cH₂ investigated that were produced from the m/z 332 ion. The 7-digit masses are the theoretical masses for compositions determined using MPPSIRD and the PGM.

The asterisks indicate fragmentations confirmed by linked scans.

CONCLUSION

136.0347 \

 (C_8H_8S)

Traditionally, to provide mass spectrometric confirmation of the identity of a synthesis product, the exact mass of the molecular ion is determined and cited as consistent with the expected elemental composition within the error limits of the mass determination. In this study, the

evidence that the product was made was far more complete. All other possible compositions based on the exact mass and its error limits were rejected, and structural details were deduced from the compositions of the fragment ions and neutral losses.

This study used high resolution mass spectrometry to provide compelling evidence that the desired synthesis product was made. Researchers with access to high resolution mass spectrometers should become aware that the capabilities of these machines for aiding in synthetic studies have been expanded by development of MPPSIRD, which operates with the B2.2 data system of VG-70S mass spectrometers and the PGM. These tools are available, free of charge, from the authors.

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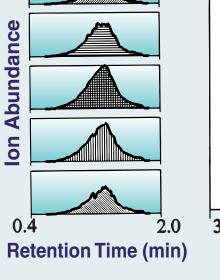
. M. S. Lee, S. E. Klohr, E. H. Kerns, K. J. Volk, J. E. Leet, D. R. Schroeder, I. E. Rosenberg, J. Mass Spectrom., 31, 1253-60 (1996). cknowledgment: The authors thank Kenneth R. Keeper for performing the synthesis and Jeffrey C. Johnson and Dr. Jeanette Van Emon for providing a sample of the product. Note: The U.S. Environmental Protection Agency (EPA), through its Office of Research and Development (ORD), funded this research and approved this abstract as a basis for a poster presentation. The actual presentation has not been peer reviewed by EPA.

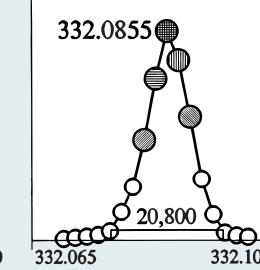
MPPSIRD

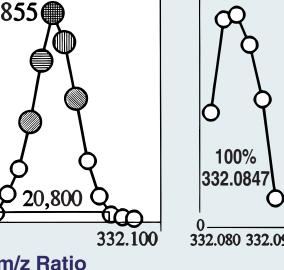
Recently, the Environmental Sciences Division of the Office of Research and Development, U.S. EPA, developed analytical tools used to determine the elemental compositions of ions formed from environmental contaminants in complex mixtures.³ The tools are a new high resolution mass spectrometric technique for acquiring data, Mass Peak Profiling from Selected Ion Recording Data (MPPSIRD), 4,5 and a Profile Generation Model (PGM)² that is used to plan experiments and interpret the data. The PGM considers error limits of the exact masses determined for the M, M+1, and M+2 mass peak profiles and the abundances of the M+1 and M+2 profiles relative to that of the M profile. Testing criteria based on five quantities, three exact masses and two relative abundances, rather than a single exact mass,

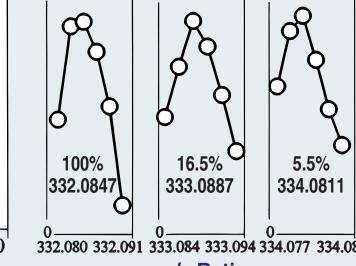
In Figure 2a are displayed ion chromatograms obtained at different m/z ratios across the mass peak profile in Figure 2b that was plotted from the areas of the shaded chromatographic peaks. Figure 2b is a full mass peak profile acquired at 20,000 (±10%) resolution with 5-ppm mass increments between the points. The chromatographic peak areas used to plot the three partial profiles in Figure 2c were acquired using a single SIR descriptor, which can monitor no more than 25 m/z ratios. From the partial profiles, the exact masses of the M+1 and M+2 partial profiles and the abundances of the M+1 and M+2 partial profiles relative to the M partial profile are obtained; the exact masses as weighted averages of the top several points and the relative abundances as the appropriate ratio of the sum of the six points for each partial profile. Partial profiles were used only to identify molecular ions. The exact mass obtained from the partial profile of a single calibration ion (not shown), which is also monitored for both full and partial profiles, is used to correct the exact masses of the analyte ions.

MPPSIRD provides about 100 times more sensitivity and 3-fold faster cycle times⁴ than KVE scanning at 10,000 resolution. However, these advantages were not important in these experiments. Here, MPPSIRD was used rather than KVE scanning for three other reasons. (i) With MPPSIRD, data interpretation was automated, whereas KVE scan data requires manual interaction to locate profile maxima and to enter reference masses. (ii) The error limits for exact mass determinations and relative abundances for the M+1 and M+2 profiles by MPPSIRD have been established and are incorporated in the PGM,⁵ which is used to reject incorrect compositions using criteria based on these quantities automatically. (iii) The computer memory requirement for data is an order of magnitude less for MPPSIRD.









2.3E4 —

m/z Ratio

Figure 2. (a) chromatographic peak areas under ion chromatograms acquired at five m/z ratios across the top of a mass peak profile. (b) a full mass peak profile plotted from chromatographic peak areas, including those in (a). (c) partial mass peak profiles for M, M+1, and M+2 ions.

IDENTIFYING FRAGMENT IONS

The compositions of fragment ions and neutral losses produced from the molecular ion reveal structural details of a compound.^{7,8} With probe introduction, composite mass spectra were observed due to impurities. A three-step process was employed to investigate prominent ions observed in Figure 1. First, the exact masses of the fragment ions at each nominal mass were determined from data acquired at 10,000, and in some cases 20,000 resolution. Second, ion chromatograms were acquired at 10,000 or greater resolution to determine which ions fragmented from the molecular ion. Linked scans acquired with low resolution (1000) were also used for this purpose. Finally, the PGM was used to determine elemental compositions of the fragment ions based on the maximum number of atoms of each element in the molecular ion. The ions labeled in Figure 1 were investigated.

of the fragment ions. COMPOSITIONS

interpretation and greater confidence in fragmentation schemes determined.

In Table 2 are listed the exact

fragmentation from the m/z 332 ion

masses of the corresponding neutral

fragment ions. The compositions in

unique elemental compositions that

based on the total number of atoms

of each element in the molecular

ion: 14 C, 21 H, 5 O, 1 P, and 1 S.

composition was possible -- the one

that corresponded to subtraction of

the composition of each fragment ion

from the composition of the molecular

For all neutral losses, only one

ion. This agreement provided a

on nominal masses

check for consistency. Obtaining

exact masses eliminated numerous

other plausible neutral losses based

and in Table 3 are listed the exact

losses determined from the mass

difference between M+· and the

the table of fragment ions are the

correspond to each exact mass

masses of 13 ions formed by

FRAGMENT IONS

result when the correct composition of each ion and neutral loss is